

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. TE2-090		SERIAL NO. 09/845,782	
<div style="border: 1px solid black; border-radius: 50%; padding: 10px; display: inline-block;"> OIPE NOV 14 2001 PATENT & TRADEMARK OFFICE </div> LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT Telect, Inc.			
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U.S. PATENT DOCUMENTS							
*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
hnh	AA	4373776	2/1983	Purdy			
hnh	AB	4,679,896	7/1987	Kratcick et al.			
hnh	AC	4,792,203	12/1988	Nelson et al.			
hnh	AD	4,824,196	4/1989	Bylander			
hnh	AE	4,840,449	6/1989	Ghandeharizadeh			
hnh	AF	4,900,123	2/1990	Barlow et al.			
hnh	AG	4,911,521	3/1990	Ryuto et al.			
hnh	AH	5,052,775	10/1991	Bossard et al.			
hnh	AI	5,119,459	6/1992	Meyerhoefer et al.			
hnh	AJ	5,127,082	6/1992	Below et al.			
hnh	AK	5,142,606	8/1992	Carney et al.			
hnh	AL	5,167,001	11/1992	Debortoli et al.			
FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Subclass	Translation
							Yes No
hnh	AM	95/29,418	11/1995	Franckx et al.			
hnh	AN	98/13,713	4/1998	Wambeke et al.			
hnh	AO	99/38,042	7/1999	Wambeke et al.			
hnh	AP	99/42,881	8/1999	Pieck et al.			
	AQ						
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)							
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hwh	AA	5,212,761	5/1993 Petrunia			
hwh	AB	5,323,478	6/1994 Milanowski et al.			
hwh	AC	5,363,467	11/1994 Keith			
hwh	AD	5,428,705	6/1995 Hermesen et al.			
hwh	AE	5,430,823	7/1995 Dupont et al.			
hwh	AF	5,450,518	9/1995 Burek et al.			
hwh	AG	5,490,229	2/1996 Ghandeharizadeh et al.			
hwh	AH	5,511,144	9/1996 Hawkins et al.			
hwh	AI	5,617,501	4/1997 Miller et al.			
hwh	AJ	5,689,605	11/1997 Cobb et al.			
hwh	AK	5,734,775	3/1998 Vidacovich et al.			
hwh	AL	5,778,131	7/1998 Llewellyn et al.			

FOREIGN PATENT DOCUMENTS							
	Document Number	Date	Country	Class	Subclass	Translation	
						Yes	No
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hmrh	AA	5,802,237	9/1998 Pulido				
hmrh	AB	5,804,765	9/1998 Siemon et al				
hmrh	AC	5,835,657	11/1998 Suarez et al.				
hmrh	AD	5,870,519	2/1999 Jenkins et al				
hmrh	AE	5,887,106	3/1999 Cheeseman et al.				
hmrh	AF	5,946,440	8/1999 Puetz				
hmrh	AG	5,987,207	11/1999 Hoke				
hmrh	AH	6,009,224	12/1999 Allen				
hmrh	AI	6,009,225	12/1999 Ray et al.				
hmrh	AJ	6,061,492	5/2000 Strause et al				
hmrh	AK	6,081,645	6/2000 Dotzer et al.				
hmrh	AL	6,215,938	4/2001 Reitmeier et al				

FOREIGN PATENT DOCUMENTS							
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						Yes	No
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	AO						
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